

## Notice of References Cited

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Application/Control No.	`Applicant(s)/Pater	nt Under
09/759,220	Reexamination HAYASHI, KEIICHI	
Examiner	Art Unit	
Julio R Perez	2681	Page 1 of 1

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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